

**Search Notes**

Application/Control No.

10/064,259

Examiner

Habte Mered

Applicant(s)/Patent under  
Reexamination

CHANG ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner
370	242	8/7/2006	HM
370	248	8/7/2006	HM
370	250	8/7/2006	HM
370	251	8/7/2006	HM
714	712	8/7/2006	HM
714	715	8/7/2006	HM
375	360, 364	8/7/2006	HM
327	18-27	8/7/2006	HM
327	28-38	8/7/2006	HM

**INTERFERENCE SEARCHED**

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370	242	8/17/2006	HM
370	248	8/17/2006	HM
714	712	8/17/2006	HM
PGPUB text search 8/17/2006, see East Search History Report		8/17/2006	HM

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Palm Inventor's Search	8/17/2006	HM
Searched IEEE	8/17/2006	HM
Searched East DB:USPG-PUB, USPAT, EPO, and JPO	8/7/2006	HM
Consulted with SPE (Hassan Kizou) on potential search classes	8/7/2006	HM
Consulted with SPE (Hassan Kizou) on allowable subject matter	8/7/2006	HM